Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,714	INOUE ET AL.
Examiner	Art Unit
A. Sefer	2826

SEARCHED					
Class	Subclass	Date	Examiner		
			-		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	_				
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PG-Pub, Derwent, EPO & JPO)	12/15/2005	AS		
257/103,22,13,76 (text search)	12/15/2005	AS		